

CPM2-1700-0045B

Silicon Carbide Power MOSFET
C2M™ MOSFET Technology
 N-Channel Enhancement Mode

V_{DS}	1700 V
$I_D @ 25^\circ\text{C}$	72 A
$R_{DS(on)}$	45 mΩ

Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness
- Resistant to Latch-Up
- Halogen Free, RoHS Compliant

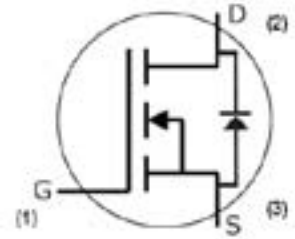
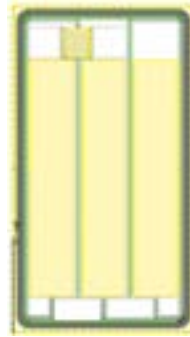
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC converters
- Motor Drive
- Pulsed Power Applications

Chip Outline



Part Number	Die Size (mm)
CPM2-1700-0045B	4.08 x 7.35

Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1700	V	$V_{GS} = 0\text{ V}, I_D = 100\ \mu\text{A}$	
V_{GSmax}	Gate - Source Voltage (Dynamic)	-10/+25	V	Absolute maximum values, AC ($f > 1\text{ Hz}$)	
V_{GSop}	Gate - Source Voltage (Static)	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	72	A	$V_{GS} = 20\text{ V}, T_C = 25^\circ\text{C}$	Note 1
		48		$V_{GS} = 20\text{ V}, T_C = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	160	A	Pulse width t_p limited by T_{jmax}	
T_J, T_{stg}	Operating Junction and Storage Temperature	-40 to +150	$^\circ\text{C}$		
T_{Proc}	Maximum Processing Temperature	325	$^\circ\text{C}$	10 min. maximum	

Note (1): Assumes a $R_{\theta JC} < 0.24\text{ K/W}$

Electrical Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1700			V	V _{GS} = 0 V, I _D = 100 μA	
V _{GS(th)}	Gate Threshold Voltage	2.0	2.4	4.0	V	V _{DS} = V _{GS} , V, I _D = 18 mA	Fig. 11
			1.8		V	V _{DS} = V _{GS} , V, I _D = 18 mA, T _J = 150 °C	
I _{DSS}	Zero Gate Voltage Drain Current		2	100	μA	V _{DS} = 1700 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current			600	nA	V _{GS} = 20 V, V _{DS} = 0 V	
R _{DS(on)}	Drain-Source On-State Resistance		45	70	mΩ	V _{GS} = 20 V, I _D = 50 A	Fig. 4,5,6
			90			V _{GS} = 20 V, I _D = 50 A, T _J = 150 °C	
g _{fs}	Transconductance		21.7		S	V _{DS} = 20 V, I _{DS} = 50 A	Fig. 7
			24.4			V _{DS} = 20 V, I _{DS} = 50 A, T _J = 150 °C	
C _{iss}	Input Capacitance		3672		pF	V _{GS} = 0 V V _{DS} = 1000 V f = 1 MHz	Fig. 17,18
C _{oss}	Output Capacitance		171				
C _{rss}	Reverse Transfer Capacitance		6.7				
E _{oss}	C _{oss} Stored Energy		105		μJ	V _{AC} = 25 mV	Fig 16
E _{ON}	Turn-On Switching Energy (SiC Diode FWD)		2.1		mJ	V _{DS} = 1200 V, V _{GS} = -5/20 V, I _D = 50 A, R _{G(ext)} = 2.5 Ω, L = 105 μH T _J = 150 °C (TO-247-3 package)	Note 3
E _{OFF}	Turn Off Switching Energy (SiC Diode FWD)		0.86				
E _{ON}	Turn-On Switching Energy (Body Diode FWD)		4.7		mJ	V _{DS} = 1200 V, V _{GS} = -5/20 V, I _D = 50 A, R _{G(ext)} = 2.5 Ω, L = 105 μH T _J = 150 °C (TO-247-3 package)	Note 3
E _{OFF}	Turn Off Switching Energy (Body Diode FWD)		0.93				
t _{d(on)}	Turn-On Delay Time		65		ns	V _{DD} = 1200 V, V _{GS} = -5/20 V I _D = 50 A, R _{G(ext)} = 2.5 Ω, Timing relative to V _{DS} Inductive load (TO-274-3 package)	Note 3
t _r	Rise Time		20				
t _{d(off)}	Turn-Off Delay Time		48				
t _f	Fall Time		18				
R _{G(int)}	Internal Gate Resistance		1.3		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q _{gs}	Gate to Source Charge		44		nC	V _{DS} = 1200 V, V _{GS} = -5/20 V I _D = 50 A Per IEC60747-8-4 pg 21	Fig. 12
Q _{gd}	Gate to Drain Charge		57				
Q _g	Total Gate Charge		188				

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V _{SD}	Diode Forward Voltage	4.1		V	V _{GS} = -5 V, I _{SD} = 25 A	Fig. 8, 9, 10 Note 2
		3.6		V	V _{GS} = -5 V, I _{SD} = 25 A, T _J = 150 °C	
I _S	Continuous Diode Forward Current		72	A	V _{GS} = -5 V	Note 2
t _{rr}	Reverse Recovery Time	70		ns	V _{GS} = -5 V, I _{SD} = 50 A, T _J = 25 °C V _R = 1200 V dif/dt = 1400 A/μs	Note 2
Q _{rr}	Reverse Recovery Charge	530		nC		
I _{rrm}	Peak Reverse Recovery Current	14		A		

Note (2): When using SiC Body Diode the maximum recommended V_{GS} = -5V

Note (3): All Switching measurements taken on a TO-247-3 package. Final values may vary depending on final package.

Typical Performance

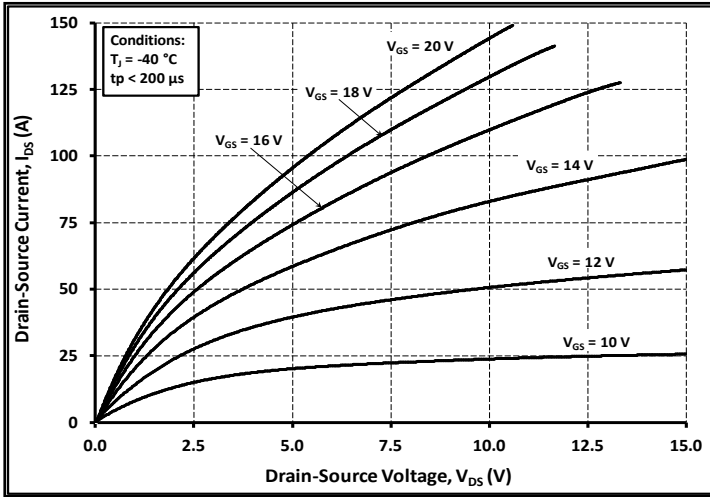


Figure 1. Output Characteristics $T_J = -40\text{ }^\circ\text{C}$

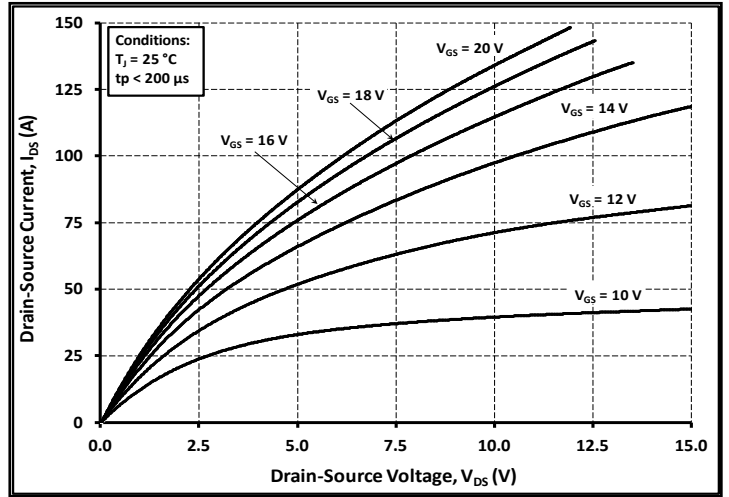


Figure 2. Output Characteristics $T_J = 25\text{ }^\circ\text{C}$

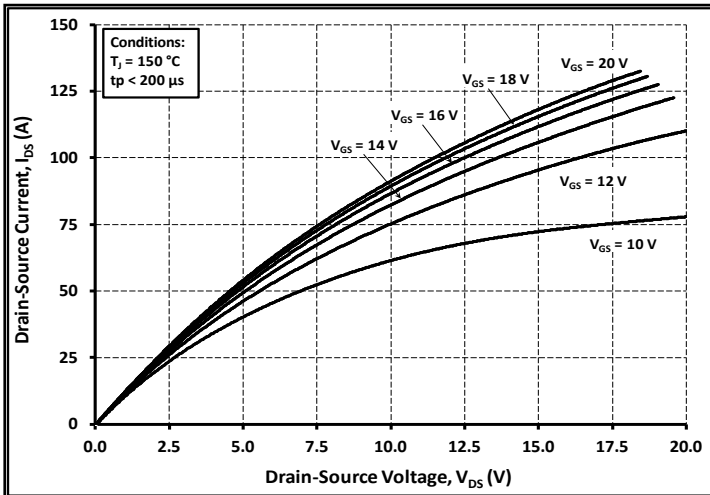


Figure 3. Output Characteristics $T_J = 150\text{ }^\circ\text{C}$

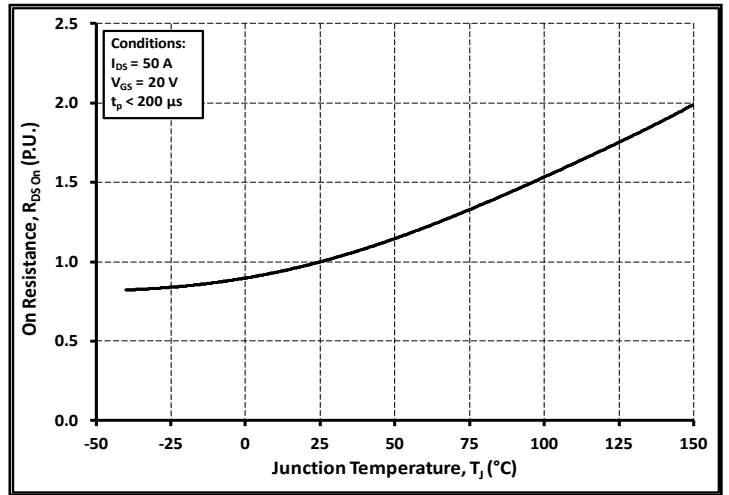


Figure 4. Normalized On-Resistance vs. Temperature

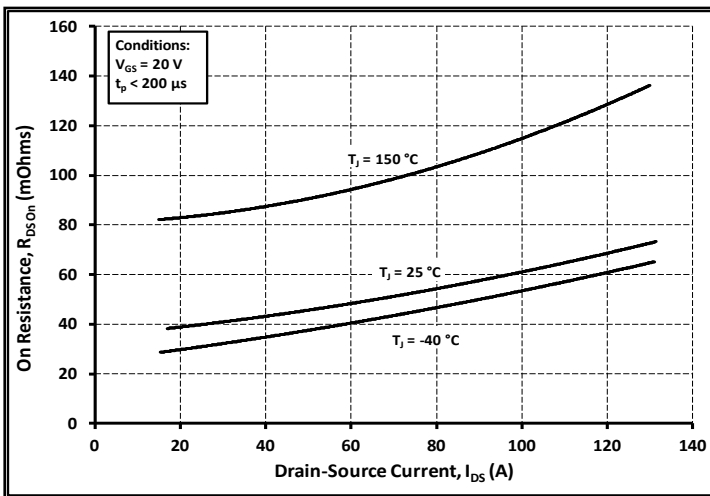


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

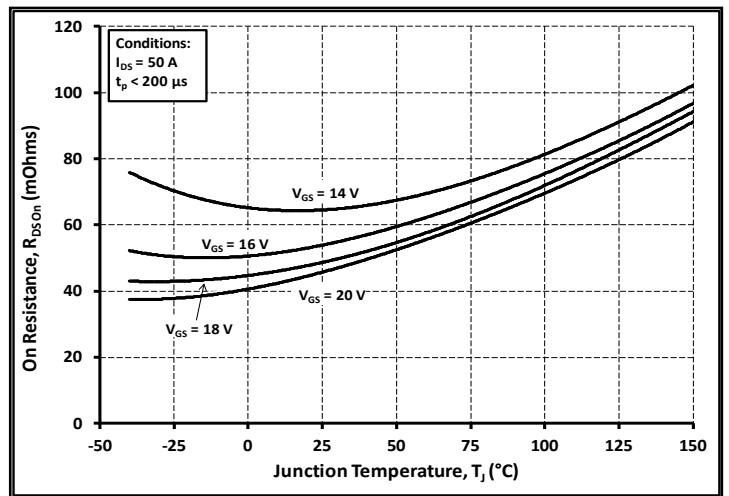


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

Typical Performance

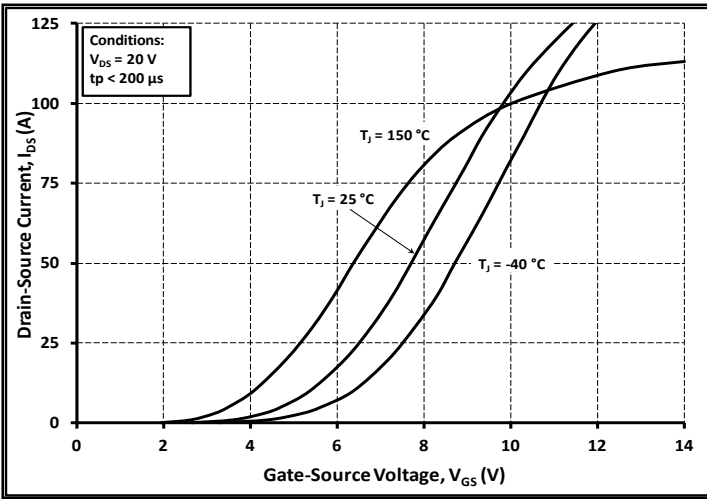


Figure 7. Transfer Characteristic For Various Junction Temperatures

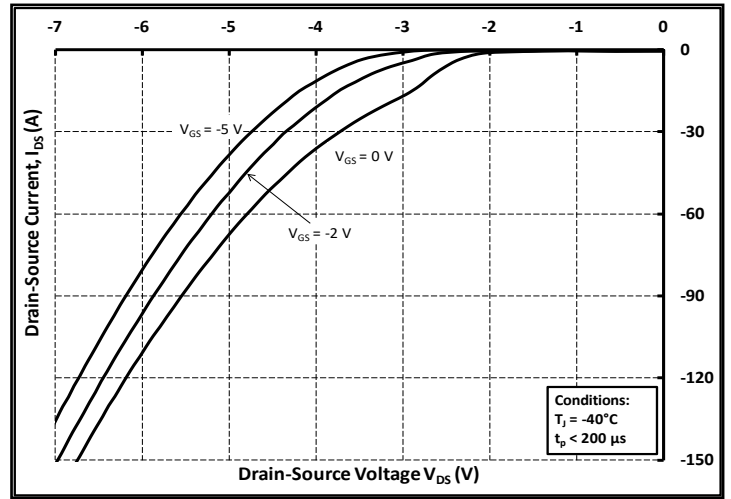


Figure 8. Body Diode Characteristic at -40°C

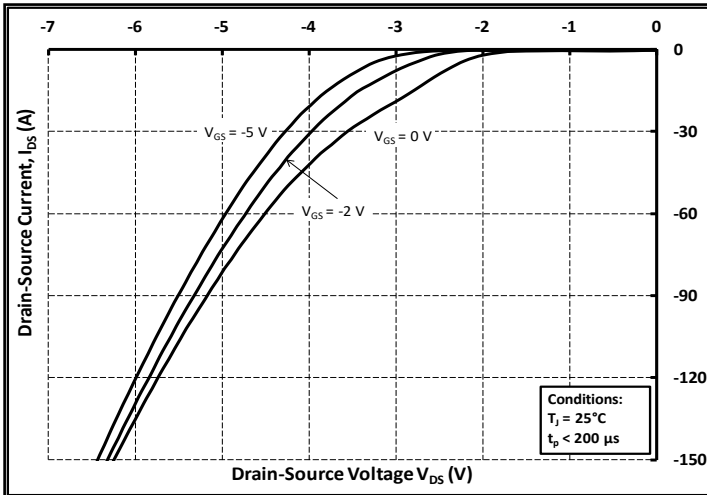


Figure 9. Body Diode Characteristic at 25°C

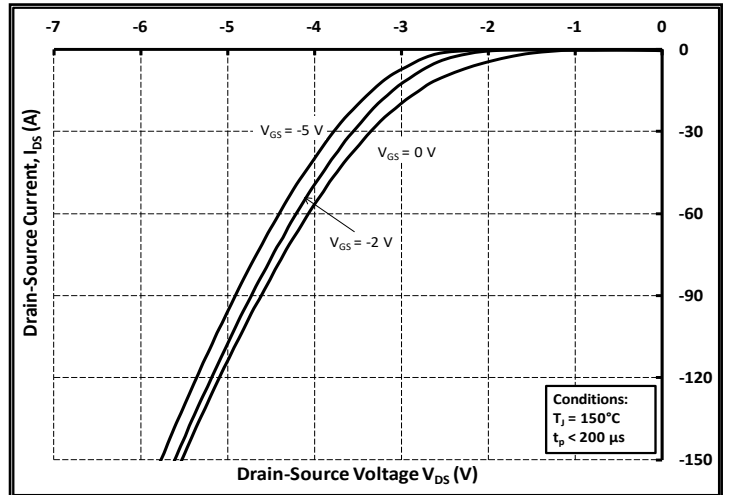


Figure 10. Body Diode Characteristic at 150°C

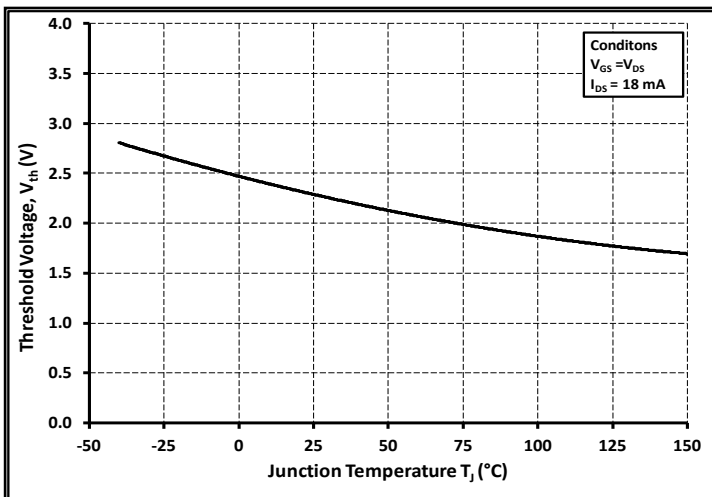


Figure 11. Threshold Voltage vs. Temperature

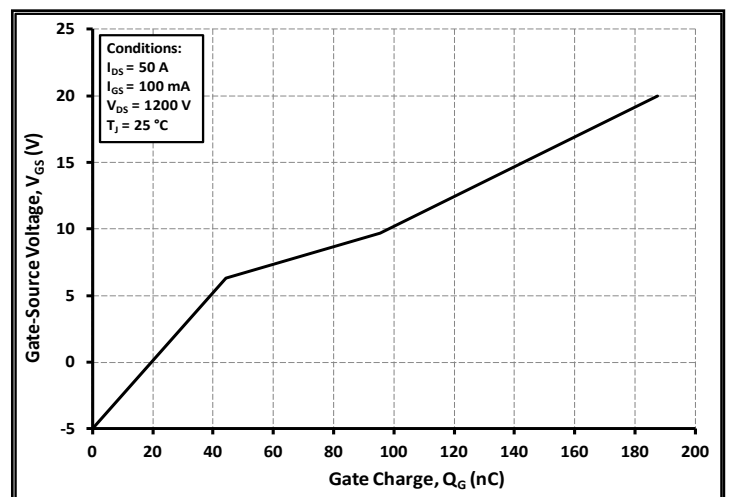


Figure 12. Gate Charge Characteristic

Typical Performance

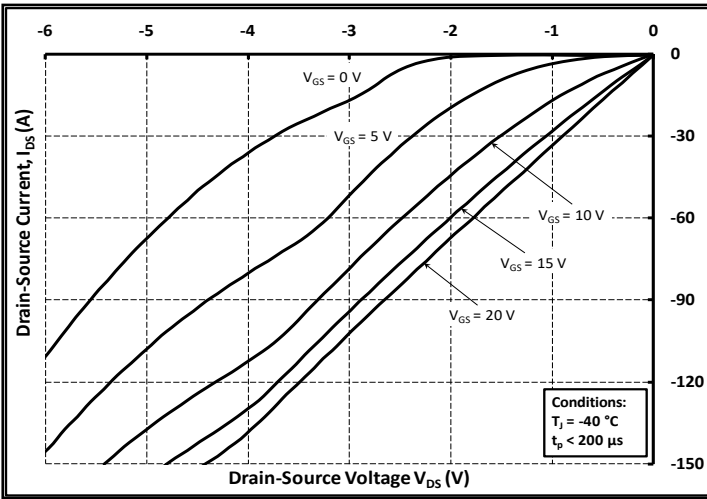


Figure 13. 3rd Quadrant Characteristic at -40 °C

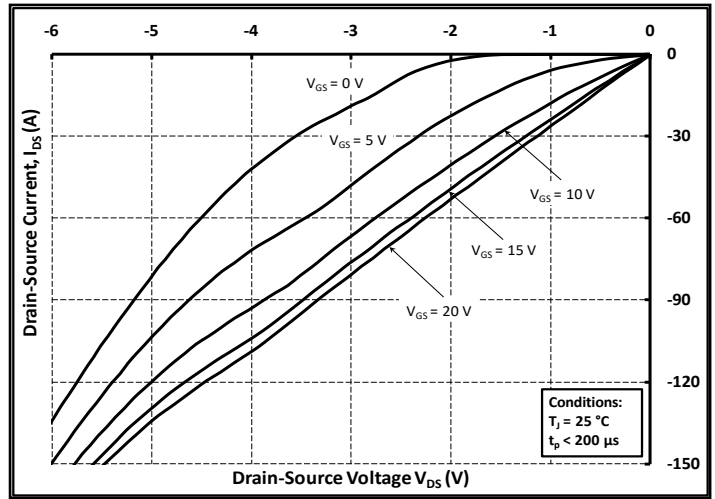


Figure 14. 3rd Quadrant Characteristic at 25 °C

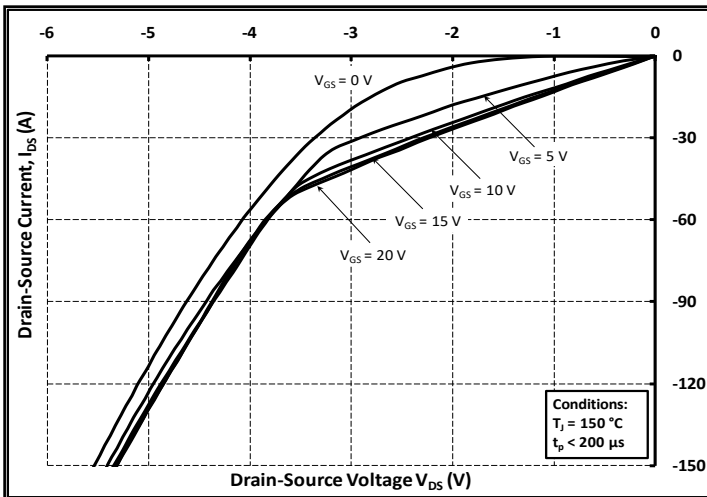


Figure 15. 3rd Quadrant Characteristic at 150 °C

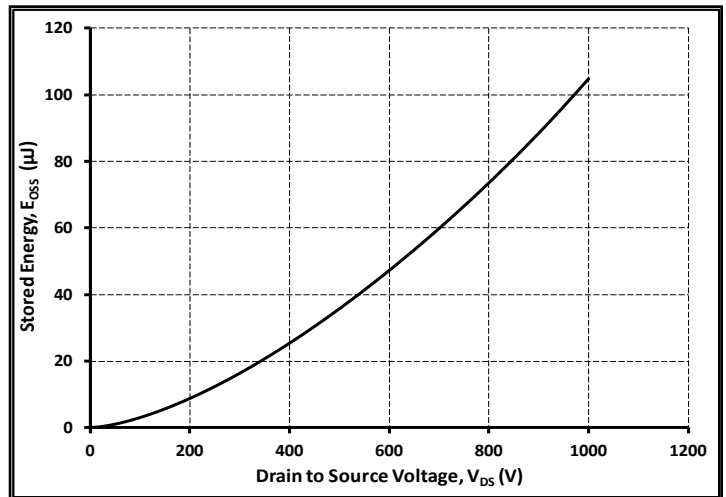


Figure 16. Output Capacitor Stored Energy

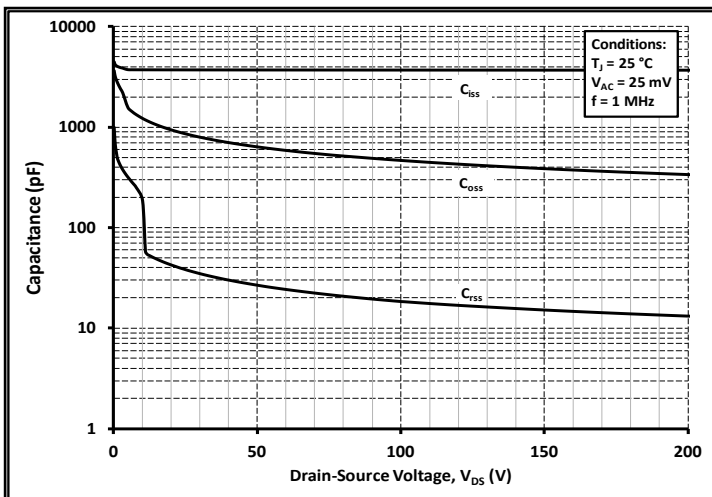


Figure 17. Capacitances vs. Drain-Source Voltage (0-200 V)

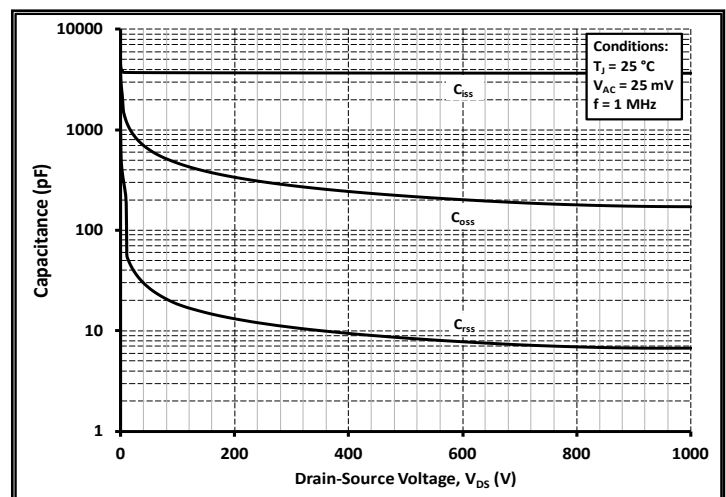
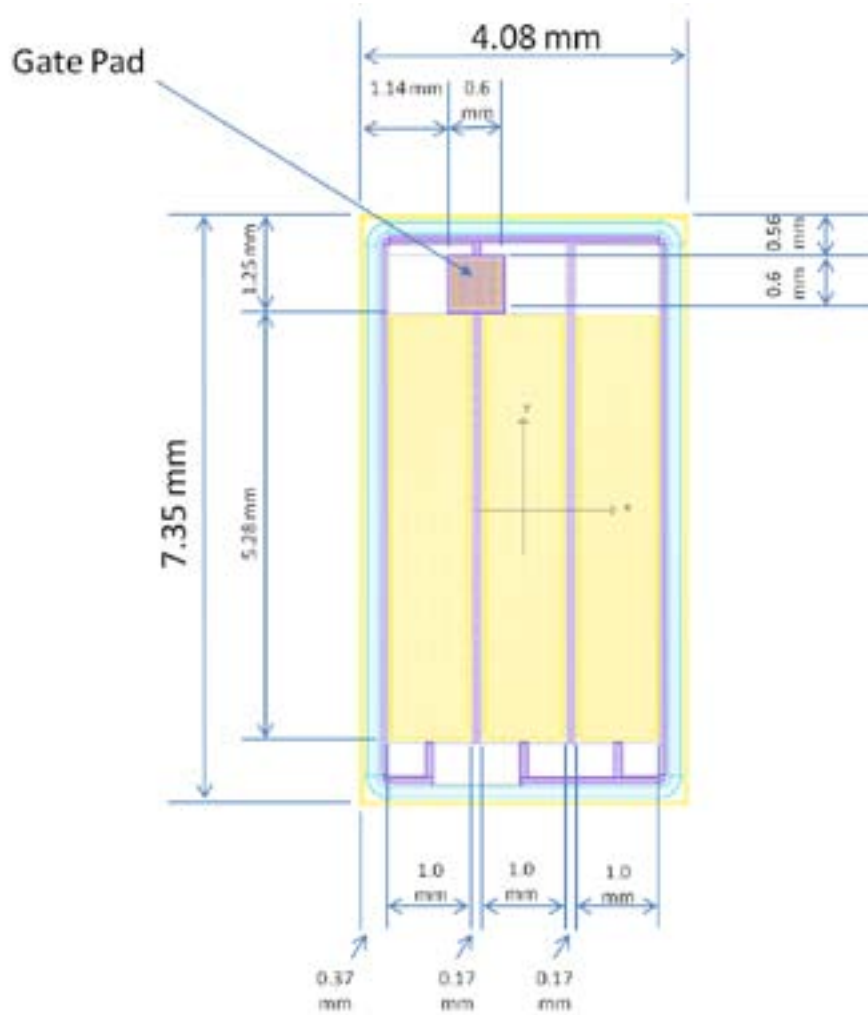


Figure 18. Capacitances vs. Drain-Source Voltage (0-1000 V)

Mechanical Parameters

Parameter	Typ	Unit
Die Dimensions (L x W)	4.08 x 7.35	mm
Exposed Source Pad Metal Dimensions	1.0 x 5.28 (x 3)	mm
Gate Pad Dimensions	0.6 x 0.6	mm
Chip Thickness	380 ± 40	µm
Frontside (Source) metallization (Al)	4	µm
Frontside (Gate) metallization (Al)	4	µm
Backside (Drain) metallization (Ni/Ag)	0.8 / 0.6	µm

Chip Dimensions



Notes

- **RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.

- **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.